

Notice of References Cited	Application/Control No. 10/520,824	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Cam N. Nguyen	Art Unit 1754	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,800,388	10-2004	Kaneko et al.	429/19
	B	US-4,200,554	04-1980	Lauder, Alan	502/326
	C	US-4,182,694	01-1980	Lauder, Alan	502/303
	D	US-5,447,705	09-1995	Petit et al.	423/418.2
	E	US-6,033,632	03-2000	Schwartz et al.	422/190
	F	US-6,569,803	05-2003	Takeuchi, Masahiko	502/328
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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